



# National Institute of Standards & Technology

## Certificate of Analysis

### Standard Reference Material<sup>®</sup> 2234

#### Gallium for Thermal Analysis

This Standard Reference Material (SRM) is intended for use in calibrating differential scanning calorimeters (DSC), differential thermal analyzers, and similar instruments. A unit of SRM 2234 consists of a small ingot (approximately 2 g) of high purity gallium (99.999 99 %), sealed in a polyethylene vial. The enthalpy of fusion and the fusion temperature were measured in an adiabatic calorimeter. Complete details of the measurements are given in reference 1.

Enthalpy of Fusion  
(J • g<sup>-1</sup>)

Fusion Temperature  
(K)

80.097 ± 0.032

302.9146 ± 0.0001

The certified values were obtained from a set of 35 adiabatic calorimetric measurements in the temperature range of 288.6 K to 314.35 K. The methods used for determination of the certified values are given in reference 1. The fusion temperature is the freezing point temperature on the International Temperature Scale of 1990.

The average of three determinations of the enthalpy of fusion, after adjusting the measured enthalpy increments for the pre-fusion and post-fusion enthalpy increment contributions, was 80.097 J • g<sup>-1</sup>. The standard deviation calculated was 0.0057 J • g<sup>-1</sup> and the standard deviation of the mean was 0.0033 J • g<sup>-1</sup>. A coverage factor of 4 was used to calculate the uncertainty of the value of the enthalpy change due to fusion, ± 0.013 J • g<sup>-1</sup>, which corresponded to ± 0.016 % of the enthalpy of fusion. To this quantity, estimated uncertainties of the extrapolations of the crystal-phase enthalpy function,  $\Delta H_{cr}(T_l \rightarrow 302.9146 \text{ K})$ , and of the calculated liquid-phase enthalpy increments,  $\Delta H_l(302.9146 \text{ K} \rightarrow T_2)$ , were added. To estimate these uncertainties, twice the root-mean-square (rms) deviation for the representations of the enthalpy increment measurements of the liquid and crystal phases, ± 0.07 %, was used to estimate the uncertainty of the sum of the pre-fusion and post-fusion enthalpy increments. This quantity is approximately ± 0.019 J • g<sup>-1</sup> and corresponds to ± 0.024 % of the enthalpy of fusion. The combination of these uncertainties gives ± 0.032 J • g<sup>-1</sup>, which corresponds to a 95 % confidence interval [3].

**Expiration of Certification:** The certification of **SRM 2234** is valid, within the measurement uncertainty specified, until **01 August 2018**, provided the SRM is handled and stored in accordance with the instructions given in this certificate (see “Instructions for Handling, Storage, and Use”). This certification is nullified if the SRM is damaged, contaminated, or modified.

**Maintenance of SRM Certification:** NIST will monitor this SRM over the period of its certification. If substantive technical changes occur that affect the certification before the expiration of this certificate, NIST will notify the purchaser. Registration (see attached sheet or register online) will facilitate notification.

Overall direction and coordination of the technical measurements leading to certification were performed by D.G. Archer formerly of NIST.

Support aspects involved in the issuance of this SRM were coordinated through the NIST Office of Reference Materials.

James Fekete, Chief  
Applied Chemicals and Materials Division

Gaithersburg, MD 20899  
Certificate Issue Date: 21 April 2015  
*Certificate Revision History on Last Page*

Robert L. Watters, Jr., Director  
Office of Reference Materials

## INSTRUCTIONS FOR HANDLING, STORAGE, AND USE

**Sample-enclosure Devices:** Commercially available sample-enclosure devices for differential scanning calorimetry or differential thermal analysis are fabricated from a variety of sources such as aluminum, gold, alumina, and steel. Of these commercial sample-holder materials, aluminum is used most commonly because of low cost and good thermal characteristics. Gallium alloys rapidly with aluminum and its alloys. However, some aluminum sample holders that have been subjected to a heat treatment (placed in an oven at 843 K for more than one hour) show resistance to alloying that allows use of the gallium for a short period of time. Note that this heat treatment procedure works with some, not all, sample holders from manufacturers. Some aluminum sample-holder components have acquired a brownish color after or while being subjected to the heat treatment; these components invariably reacted with an enclosed sample of gallium. Anodization of aluminum pans is not the same thing as the heat treatment described above.

**Storage Instructions:** When not in use, store SRM 2234 in the packaging provided or in a manner that provides equivalent or better protection against loss or damage.

**Use:** Specific instructions for use, other than those specified above regarding the stabilization of aluminum DSC pans prior to use with this material, depend on the calibration protocol being used. Reference 2 is one such protocol.

## REFERENCES

- [1] Archer, D.G.; *The Enthalpy of Fusion of Gallium*; J. Chem. Eng. Data, Vol. 47, pp. 304–309 (2002).
- [2] ASTM E967-03; *Standard Practice for Temperature Calibration of Differential Scanning Calorimeters and Differential Thermal Analyzers*; Annu. Book ASTM Stand., Vol. 14.02 (2003).
- [3] JCGM 100:2008; *Evaluation of Measurement Data - Guide to the Expression of Uncertainty in Measurement*; (ISO GUM 1995 with Minor Corrections), Joint Committee for Guides in Metrology (JCGM) (2008); available at [http://www.bipm.org/utls/common/documents/jcgm/JCGM\\_100\\_2008\\_E.pdf](http://www.bipm.org/utls/common/documents/jcgm/JCGM_100_2008_E.pdf) (accessed Apr 2015); see also Taylor, B.N.; Kuyatt, C.E.; *Guidelines for Evaluating and Expressing the Uncertainty of NIST Measurement Results*; NIST Technical Note 1297, U.S. Government Printing Office: Washington, DC (1994); available at <http://www.nist.gov/pml/pubs/index.cfm> (accessed Apr 2015).

**Certificate Revision History:** 21 April 2015 (Change of expiration date; editorial changes); 18 May 2012 (Extension of certification period; editorial changes); 17 September 2004 (Original certificate date).

*Users of this SRM should ensure that the Certificate of Analysis in their possession is current. This can be accomplished by contacting the SRM Program: telephone (301) 975-2200; fax (301) 948-3730; e-mail [srminfo@nist.gov](mailto:srminfo@nist.gov); or via the Internet at <http://www.nist.gov/srm>.*